

Search Notes



Application/Control No.

09/778,961

Examiner

Tekchand Saidha

Applicant(s)/Patent under
Reexamination

YAN ET AL.

Art Unit

1652

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 435 | 198 | | |
| | 252.3 | | |
| | 320.1 | | |
| 536 | 23.2 | 5/31/2005 | TEK |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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| 435 | 198 | | |
| | 252.3 | | |
| | 320.1 | 5/31/2005 | TEK |
| 536 23.2 | | 5/31/2005 | Tek |

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR |
|---|-----------|------|
| SEQ ID Nos. 1-3 (search enclosed) <i>(SEQ ID NO: 3 was search in fragments only)</i> | 5/31/2005 | TEK |
| Selected STN and West searches are enclosed. | 5/31/2005 | TEK |
| Inventor name search | 5/31/2005 | TEK |
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